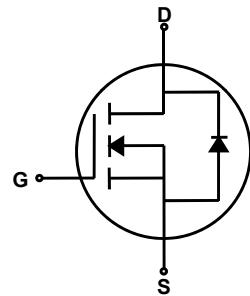
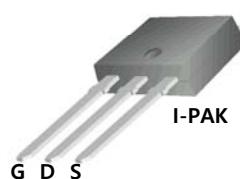
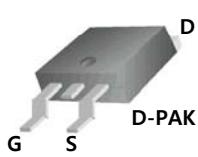


General Description

This Power MOSFET is produced using Maple semi's Advanced Super-Junction technology. This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for AC/DC power conversion in switching mode operation for higher efficiency.

Features

- 7A, 700V, $R_{DS(on)typ} = 0.52\Omega @ V_{GS} = 10\text{ V}$
- Low gate charge (typical 18nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	SLD70R600S2	SLU70R600S2	Units
V_{DSS}	Drain-Source Voltage	700		V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$)	7		A
	- Continuous ($T_C = 100^\circ\text{C}$)	4.4		A
I_{DM}	Drain Current - Pulsed	(Note 1)	28	A
V_{GSS}	Gate-Source Voltage		± 30	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	400	mJ
I_{AR}	Avalanche Current	(Note 1)	11	A
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	15	V/ns
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	125		W
	- Derate above 25°C	1.0		W/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	$^\circ\text{C}$

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	SLD70R600S2	SLU70R600S2	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.0		$^\circ\text{C}/\text{W}$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	--		$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5		$^\circ\text{C}/\text{W}$

Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	700	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C	--	0.6	--	$\text{V}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 700 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1	μA
		$V_{\text{DS}} = 560 \text{ V}, T_C = 125^\circ\text{C}$	--	--	10	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	2.0	--	4.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 3.5 \text{ A}$	--	0.52	0.6	Ω
R_g	Gate resistance	F=1MHZ	--	4.9	--	Ω

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{\text{DS}} = 100 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	494	--	pF
C_{oss}	Output Capacitance		--	27	--	pF
C_{rss}	Reverse Transfer Capacitance		--	1.7	--	pF

Switching Characteristics

$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 350 \text{ V}, I_D = 7.0 \text{ A}, R_G = 24 \Omega$ (Note 4, 5)	--	10	--	ns
t_r	Turn-On Rise Time		--	28	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	53	--	ns
t_f	Turn-Off Fall Time		--	26	--	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 560 \text{ V}, I_D = 7.0 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5)	--	18	--	nC
Q_{gs}	Gate-Source Charge		--	3.9	--	nC
Q_{gd}	Gate-Drain Charge		--	9.3	--	nC

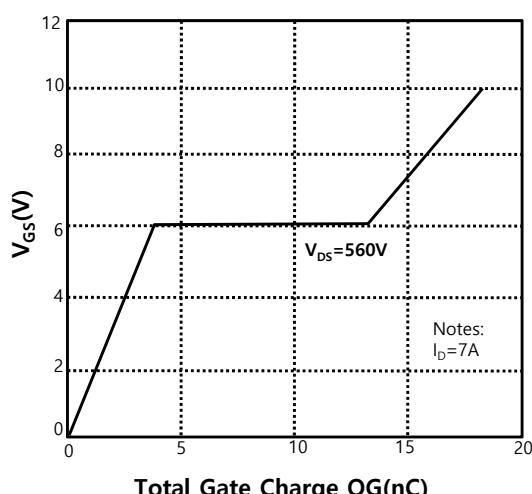
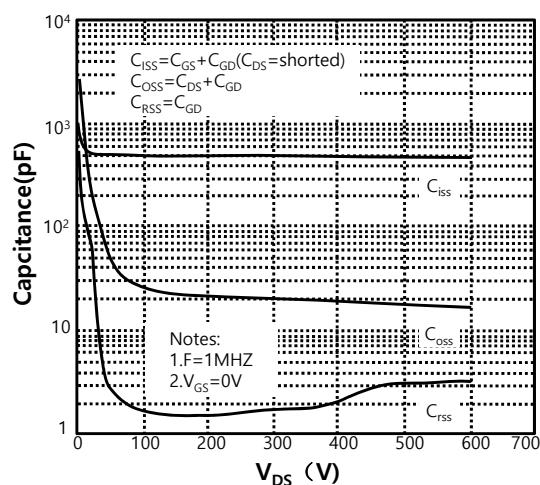
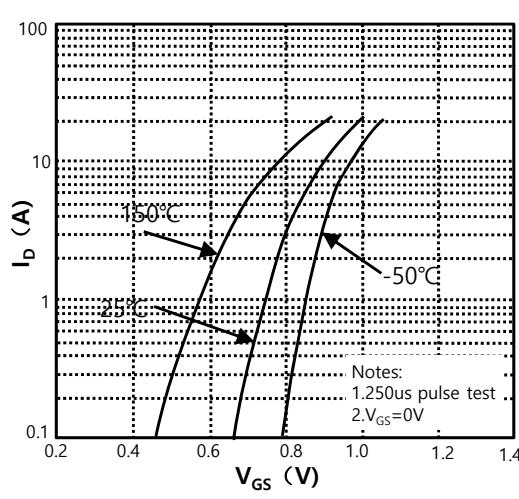
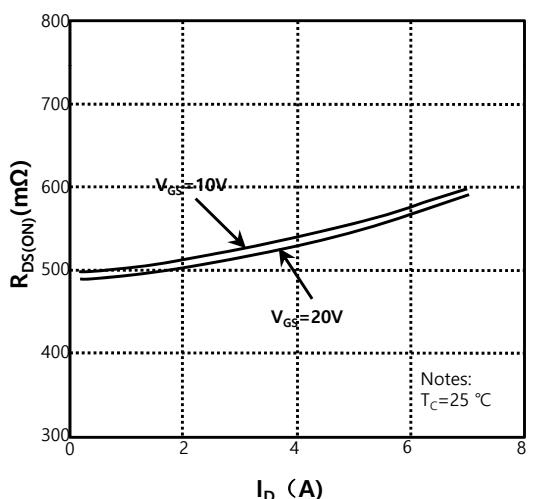
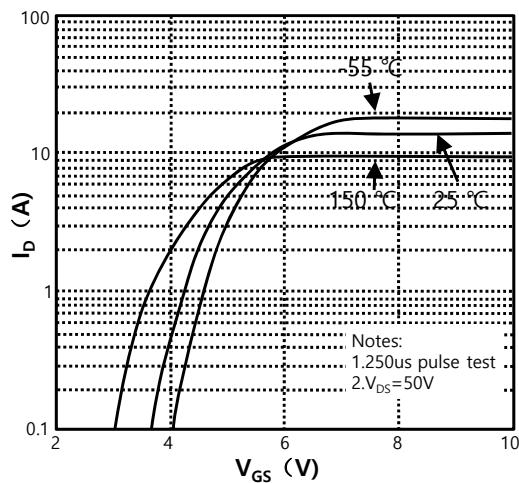
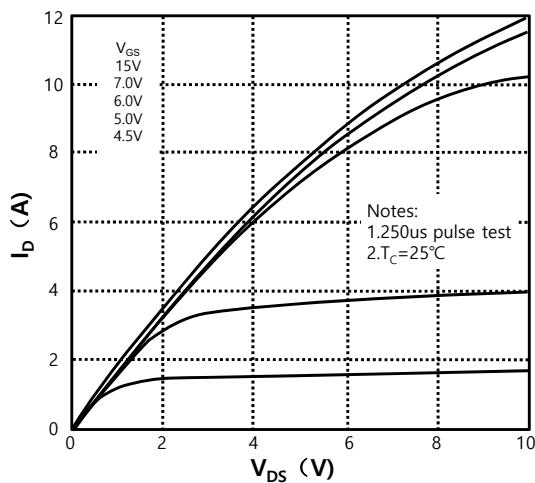
Drain-Source Diode Characteristics and Maximum Ratings

I_S	Maximum Continuous Drain-Source Diode Forward Current	--	--	7.0	A	
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	28	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_S = 7.0 \text{ A}$	--	--	1.4	V
t_{rr}	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}, I_S = 7.0 \text{ A}, dI_F / dt = 100 \text{ A/us}$ (Note 4)	--	317	--	ns
Q_{rr}	Reverse Recovery Charge		--	2.8	--	uC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $L = 79 \text{ mH}, I_{\text{AS}} = 3.2 \text{ A}, V_{\text{DD}} = 100 \text{ V}, R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{\text{SD}} \leq 7.0 \text{ A}, di/dt \leq 100 \text{ A/us}, V_{\text{DD}} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300 \mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

Typical Characteristics



Typical Characteristics (Continued)

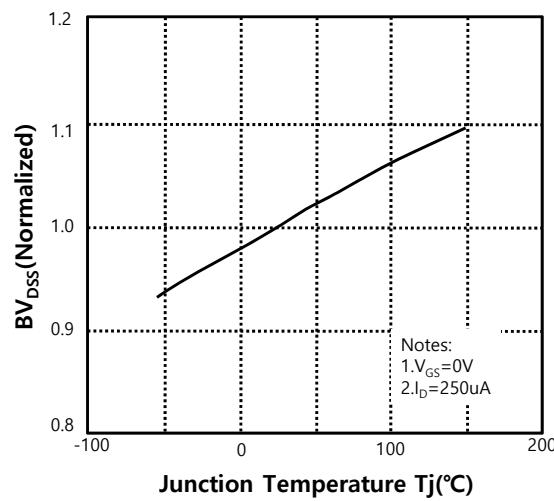


Figure 7. Breakdown Voltage Variation vs Temperature

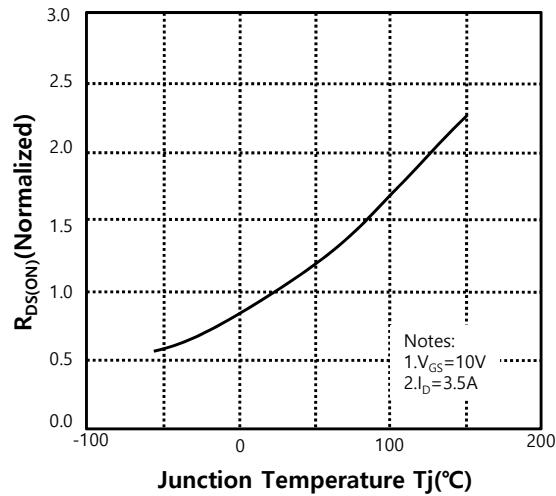


Figure 8. On-Resistance Variation vs Temperature

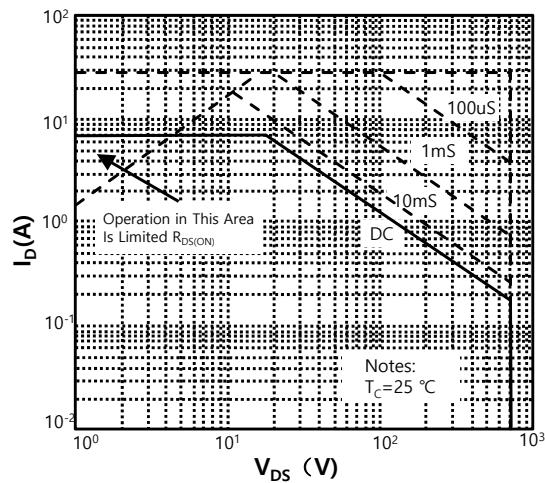


Figure 9. Maximum Safe Operating Area

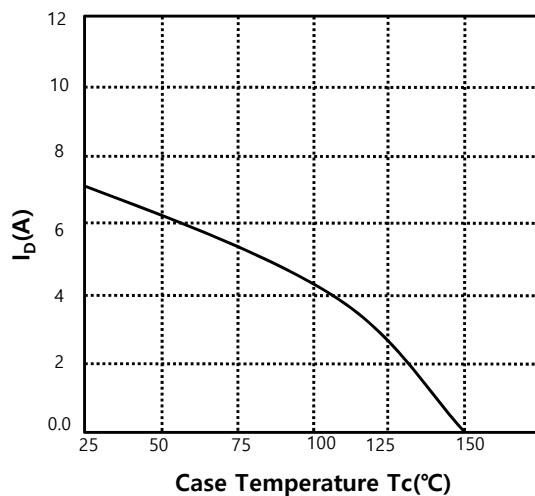
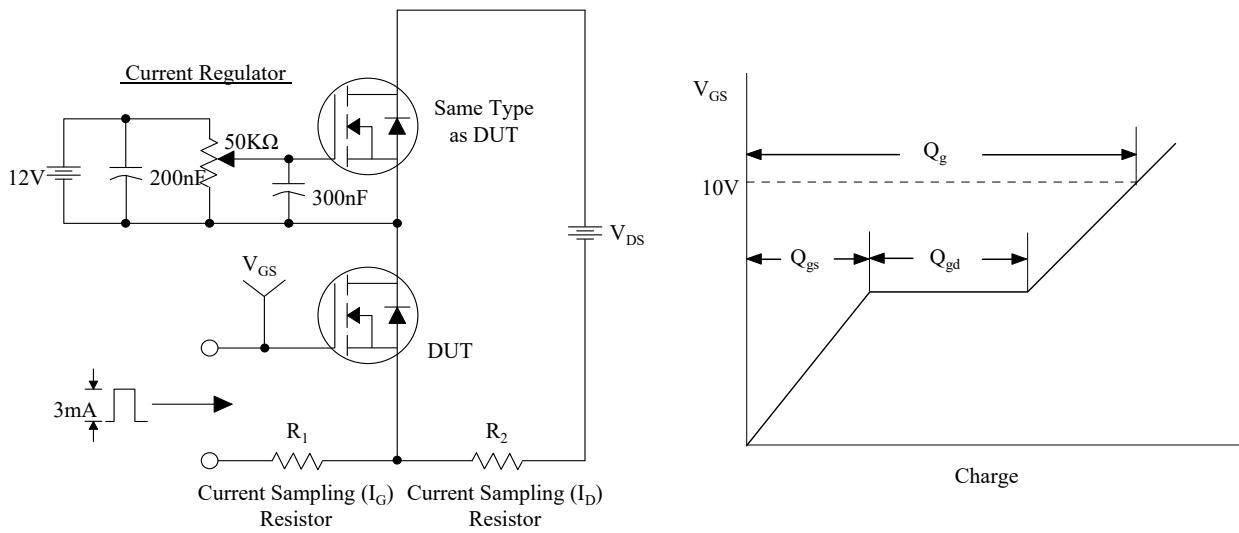
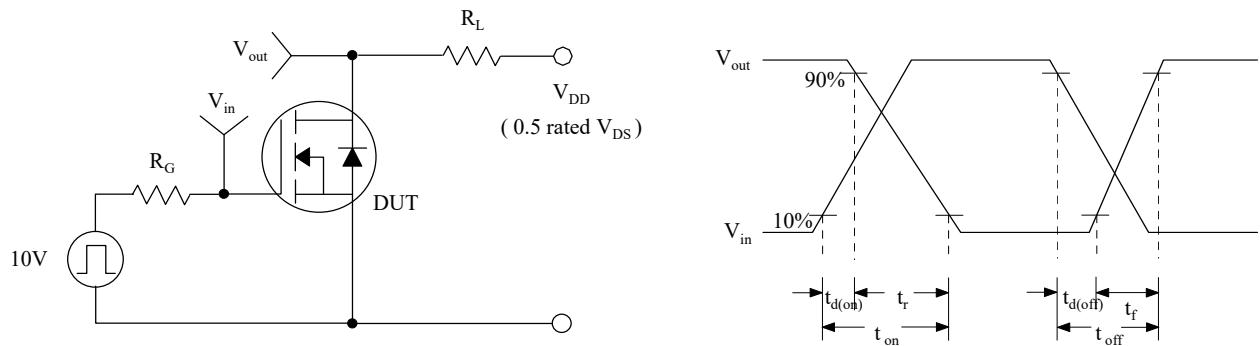


Figure 10. Maximum Drain Current vs Case Temperature

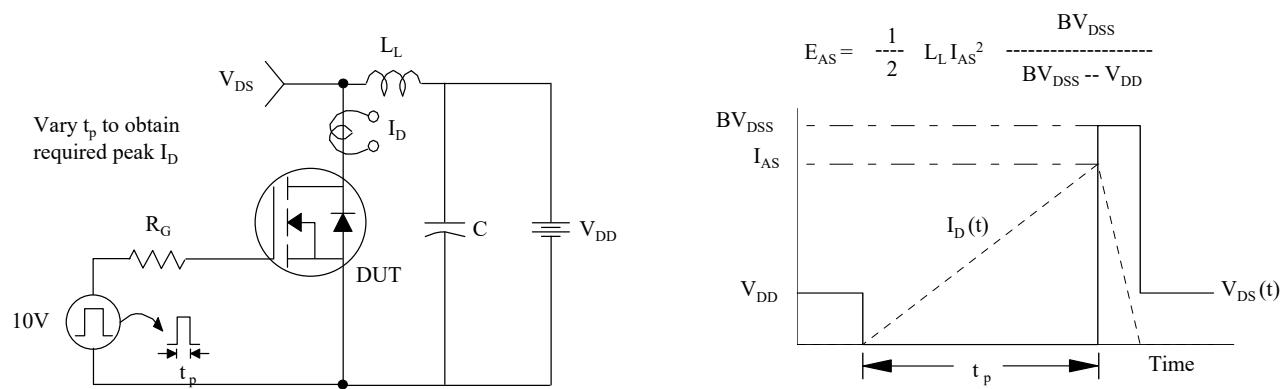
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms

